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Optical emission due to ionic displacements in alkaline earth titanates

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Abstract

Optical emission spectra in the 300–700 nm range were collected from single crystal CaTiO₃, SrTiO₃ and BaTiO₃, and polycrystalline CaTiO₃ samples, that were irradiated at room temperature using a Febetron 706 variable energy pulsed-electron-beam generator. The long-lived emissions (up to microseconds after the electron pulse) consist of broad (halfwidths \sim 100 nm) bands centred around 380, 425, and 445 nm for CaTiO₃, SrTiO₃ and BaTiO₃, respectively. These emission bands are similar to cathodoluminescence emissions from 25 keV electron irradiation attributed by others to direct conduction-valence band transitions in unreduced samples and oxygen vacancies in reduced samples. CaTiO₃, SrTiO₃ and BaTiO₃ all have emission thresholds of 0.26 \pm 0.02 MeV. This corresponds to a threshold displacement energy for oxygen, E_d of 45 \pm 4 eV. © 2001 Elsevier Science B.V. All rights reserved.

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1. Introduction

Perovskite, CaTiO₃, is a key phase in some varieties of Synroc [1], a family of titanate ceramics designed for high-level radioactive waste immobilisation. The waste contains actinide ions that, when incorporated in the crystalline Synroc, give rise to lattice damage, primarily from the alpha-recoil nucleus of mass ~210–240 amu and energy ~80–100 keV. Approximately 1500 atoms are displaced in each event [2]. Hence perovskite (and other phases) in Synroc is prone to structural disordering from radiation damage. These effects have been evidenced in X-ray diffraction studies of Synroc doped with the short-lived actinide emitters Cm-244 [3] and Pu-238 [4]. Lattice damage effects have also been observed in heavy-ion irradiation [5,6] of perovskite, using transmission electron microscopy (TEM). However

Various techniques have been used to monitor defect production and/or expose the presence of pre-existing defects in irradiated non-metals. In principle, displaced ions can be detected directly using high resolution TEM. However difficulties associated with sampling and matching of simulated to experimental images make its application impractical. TEM can be used at lower resolution to detect aggregates of point defects such as dislocation loops. Rutherford back scattering on single crystals can be used to detect displaced ions, which have formed interstitials that severely interfere with ion channeling. Positron annihilation lifetime spectroscopy has been used in semiconductors to study irradiationinduced vacancies. Anion vacancies in alkali halides and alkaline earth oxides give rise to optical absorption from F centres that can be detected using cathodoluminescence (CL) or electron spin resonance (ESR) if they contain unpaired electron spins. In this study, alkaline earth titanates were monitored using time resolved CL spectroscopy.

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there is currently no information on the identity of the radiation-induced fundamental point defects in CaTiO₃.

Various techniques have been used to monitor defect

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Time resolved CL spectroscopy (TRCS) involves irradiating the sample with fast electrons (0.2–0.6 MeV) and monitoring the ultraviolet/visible luminescence produced by short-lived F type centres. For relativistic particles such as electrons, the maximum energy $T_{\rm m}$ (in eV) transferable from an incident electron of energy E (in MeV) to a lattice ion of mass number A is given [7] by:

$$T_{\rm m} = 2147.7E(E+1.022)/A.$$
 (1)

Consequently, it is possible to determine whether or not atomic displacement occurs upon irradiation by monitoring the change in emission as a function of incident electron energy. If a threshold is observed to occur at incident electron energy E, then the energy $T_{\rm m}$ is equal to the displacement energy $E_{\rm d}$ of the atom or ion in the lattice. TRCS has been successfully used to determine the $E_{\rm d}$ values of various oxides including CaO [8] and MgO [9].

The creation of F-type centres in alkaline earth oxides, single anion vacancies (F^{2+}) produced by displacements which then capture one or two electrons (F^{+}) and F centres, respectively), results in the production of characteristic luminescence upon excitation by high-energy photons. The creation process can be represented by:

$$F^{2+} + e \rightarrow F^+$$

$$F^{+*} \rightarrow F^+ + hv$$

where * denotes an excited state. In CaO for example, the 375 nm emission band has been shown [10] to occur from the relaxation of an excited F^+ centre. The 380 nm emission in MgO has been assigned to a similar centre. More recently [11,12], the 330 nm emission in sapphire (Al₂O₃) has also been ascribed to an F^+ centre relaxation.

2. Experimental

The single crystal perovskite samples used in this study were $2 \times 2 \times 10 \text{ mm}^3$ slices of high-quality single crystals (originally $2 \times 10 \times 10 \text{ mm}^3$ in size) purchased from Escete (Netherlands). The polycrystalline CaTiO₃ sample was made via the alkoxide/nitrate route [1] and sintered in air at 1400°C.

A Febetron 706 (Hewlett Packard, Field Emission Division) pulsed electron beam generator was used at room temperature to irradiate the samples. Pulses of electrons of duration 3 ns (FWHM) and a designated energy from 0.2–0.6 MeV could be produced. The energy of the designated electron energies is accurate to within 5–10%, as determined by beam penetration through gold and aluminium foils of known thickness.

The maximum output of the Febetron at 0.6 MeV is 12 J. The diameter of the electron beam was $\sim 2 \text{ cm}$. The relative dose per pulse delivered by the electron accelerator was calibrated at intervals over the energy range 0.2-0.6 MeV using a 'radiochromic' dosimetry technique [13]. The calibrations were fitted to an appropriate spline function, which was then used to interpolate doses at intermediate beam energies.

The light emission from the sample was observed at 90° to the axis of the electron beam via a system of quartz lenses focussing onto the slits of a monochromator (Spex Industries, Minimate 1670). Typically, a bandpass of 2 nm was used to record emission spectra, and 5 nm was used for threshold determinations. This latter condition allowed greater sensitivity at low electron beam energies. For emission spectra that show no sharp features, this procedure is valid.

The sample was mounted centrally in front of the electron beam window, with the [100] face at approximately 45° to the axis of the electron beam. Consequently, the electron irradiations were not along any specific crystallographic direction. The beam was collimated to about 6 mm diameter, which was usually greater than the dimensions of the sample. The crystal and mount were contained in an aluminium vessel equipped with high purity quartz windows through which emissions from the irradiated crystal could be observed. The irradiation vessel was mounted directly on to the front of the Febetron and was routinely evacuated to less than 10^{-3} Torr prior to irradiation. This procedure was followed to eliminate emissions from components in air (mainly N₂ and H₂O fragments), which occur in the 300-400 nm region of the spectrum and have comparable lifetimes to those anticipated for F-type luminescent defects.

The output from the optical system was monitored with a photomultiplier (EMI, 9783B), displayed on a digitizing/digital oscilloscope (Tektronix, TDS 744A) and exported to a Macintosh Quadra PC for further analysis. The risetime of this system was of the order of 10 ns. The time between pulses at different wavelengths or energies was about 30 s.

Photoluminescence (PL) measurements of CaTiO₃ and SrTiO₃, irradiated with the Febetron were made using a Perkin Elmer LS 50 Photoluminscence Spectrometer. PL spectra were corrected for system response.

3. Results

In all samples, light emission was observed immediately after the electron beam pulse (see Fig. 1), if the pulse energy was greater than the displacement threshold. The emission had a rapid initial decay over a period of 50 ns but the decay merged into a long 'tail' which continued for a period of many microseconds. The

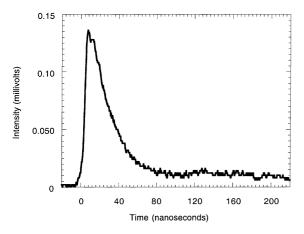


Fig. 1. Intensity of light (at 390 nm) emitted from a CaTiO₃ perovskite sample irradiated at room temperature as a function of time.

decay of emission did not follow a simple decay. This is typical of solid state dispersion kinetics behaviour, which involves a distribution of centres participating in recombination processes leading to luminescence [14]. This model gives rise to a power law time dependence of intensity (intensity is proportional to time^{-y}, where y is in the range 1–2, as per Fig. 1).

Over the electron energy range used in this study, the time-dependent profile of the emission did not discernibly change. This means that the observation of a single intensity at a fixed time after the pulse is directly proportional to the integrated light yield. In this study, wavelength-dependent spectra were recorded by measuring the intensity of emission 25 ns after the electron beam pulse. Three measurements were made at each wavelength. The wavelength range scanned was usually from 300 to 600 nm depending on the specific spectral features. Recordings were made at 10 nm intervals, except around emission maxima where some readings were taken at 5 nm intervals. The shape and intensity of the spectra did not depend on the order in which data was taken. This suggests electron irradiation causes no observable permanent defect concentrations.

Fig. 2 shows the spectra recorded at room temperature for single crystal specimens of CaTiO₃, SrTiO₃ and BaTiO₃. The maximum emissions for CaTiO₃, SrTiO₃ and BaTiO₃ occur at around 380, ~420 and ~445 nm, respectively. This distinct shift towards longer wavelengths occurs as calcium is replaced with successively heavier alkaline earth cations.

A sample of polycrystalline CaTiO₃, of similar overall size to the single crystal CaTiO₃ sample, was also irradiated at room temperature using the Febetron. The emission intensity and spectra of the polycrystalline sample are essentially identical to those of the CaTiO₃ single crystal (Fig. 3). This indicates that emission from

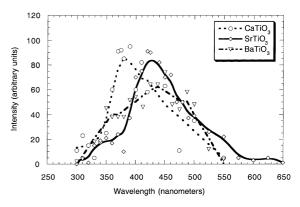


Fig. 2. Room temperature luminescence spectra from single crystal CaTiO₃, SrTiO₃ and BaTiO₃.

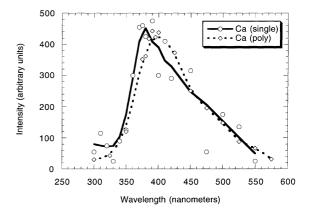


Fig. 3. Comparison of room temperature luminescence spectra from single crystal and polycrystalline CaTiO₃.

surface damage sites or at grain boundaries is not a significant factor and that the emission is from sites located within the bulk of the material. However, the grain size was ${\sim}10~\mu m$ and so the grain boundary scattering would dictate that the emission was mostly derived from a surface layer no more than ${\sim}10~\mu m$ thick.

Fig. 4 shows the emission yield per dose versus the electron beam energy at room temperature for the four samples studied. All the samples show a distinct threshold for the onset of the emission at around 0.26 MeV. Within experimental error, all four curves shown can be interpreted as having a common intercept of 0.26 ± 0.02 MeV. Using Eq. (1) and assuming oxygen ion displacement, this gives a value for the displacement energy of oxygen, $E_{\rm d}$ (oxygen), of 45 \pm 4 eV. Because of the random orientation of the single crystals and the overall agreement with the polycrystalline results for CaTiO₃, the measured displacement energies are likely the overall minimum threshold displacement energies for these perovskites.

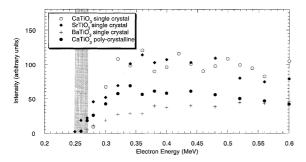


Fig. 4. Graphs of the intensity emitted by CaTiO₃, SrTiO₃ and BaTiO₃ at room temperature as a function of energy.

We measured the room temperature PL due to residual defects in irradiated $CaTiO_3$ and $SrTiO_3$. The signals are weak, indicating very low permanent defect concentrations, in agreement with the deductions stated above.

4. Discussion

The prompt CL observed in our pulsed experiments is similar in wavelength dependence to that seen in steady irradiation experiments reported by Ihrig et al. [15]. Using a continuous 25 keV electron beam, they

recorded the luminescence spectra of SrTiO₃ and BaTiO₃ after various pre-treatments. Low energy (<30 keV) electron beams are not able to generate atom/ ion displacements but will excite existing F-type centres. All the samples studied by Ihrig et al. showed emission spectra over the 350–600 nm range with partially resolved peaks in the 400–500 nm region. Samples that were pre-treated in a reducing atmosphere gave the largest CL signals because of the large concentrations of F-type centres they contained. The spectra Ihrig et al. collected from reduced SrTiO₃ and BaTiO₃ show a similar shift in wavelength to that observed between the SrTiO₃ and BaTiO₃ spectra collected in this study.

Weber et al. [16] saw significant annealing of oxygen vacancies in $SrTiO_3$ at temperatures between 200 and 400 K, in agreement with our PL results, which demonstrates that room temperature electron irradiation of $CaTiO_3$ and $SrTiO_3$ causes negligible quantities of permanent defects.

Zinkle and Kinoshita [17] collated all available $E_{\rm d}$ data for ${\rm Al_2O_3}$, MgO, MgAl₂O₄, ZnO, UO₂, and BeO including those measured using optical absorption, TEM (loops), luminescence, resistivity and ESR. The threshold values and $E_{\rm d}$ (oxygen) values calculated from the data measured in this study are similar to: (a) the $E_{\rm d}$ (oxygen) values recommended by Zinkle and Kinoshita [17] for MgO and ${\rm Al_2O_3}$, and (b) those determined by TRCS for oxygen in other oxides (see Table 1).

Table 1 Comparsion of oxygen coordination, oxygen–metal bond lengths and E_A (oxygen) values in various oxides

Material formula/ oxygen site	Coordination of oxygen site	Bond type	Bond lengths ^a (Å)	Average bond length (Å)	$E_{\rm d}({\rm oxygen})~({\rm eV})$
CaO ^b	6	O–Ca	6 × 2.4053	2.4053	58 ± 2^{c}
MgO^d	6	O–Mg	6×2.1085	2.1085	$50^{\rm e}, 55 \pm 2^{\rm c}$
$Al_2O_3^f$	4	O–Al	2×1.8554 and 2×1.9724	1.9124	$50^{\rm e},\ 49\pm2^{\rm c}$
Perovskite ^g	6	O(1)–Ca	2.4669, 2.5000, 2.8955 and 2.9877	2.4493	$45\pm4^{\rm h}$
CaTiO ₃ /O(1)		O(1)–Ti	1.9228, 1.9228		
Perovskite ^g CaTiO ₃ /O(2)	5	O(2)–Ca O(2)–Ti	2.5519, 2.5838 and 2.6844 1.9244 and 1.9280	2.3345	$45\pm4^{\text{h}}$
Perovskite ⁱ SrTiO ₃	6	O–Sr O–Ti	4×2.7613 2×1.9525	2.4917	$45\pm4^{\rm h}$
Perovskite ^g BaTiO ₃ / O(1)	6	O(1)–Ba O(1)–Ti	4 × 2.8290 1.8724 and 2.1456	2.5557	$45\pm4^{\rm h}$
Perovskite ^g BaTiO ₃ / O(2)	6	O(2)–Ba O(2)–Ti	2×2.8778 2 × 2.7923 and 2 × 2.0043	2.5581	$45\pm4^{\rm h}$

^a As calculated by 'CrystalMaker 4.0', a Mac based PC program for drawing and analysing crystallographic structures.

^bF.D. Bloss, 'Crystallography and Crystal Chemistry', Holt Rinehart and Winston, USA (1971) 241.

^c Values measured by 11.

^d Sasaki S, Fujino K, Takeuchi Y, Proceedings of the Japan Academy, 55 (1979) 43.

^e Values recommended by Zinkle and Kinoshita [17].

^f Finger and Hazen, J. Appl. Phys. 49 (1978) 5823.

^g Wyckoff R.W.G., Crystal Structures, 2nd ed., Interscience, New York, Vols. 1–3, 1981–86.

^h Values measured in this study.

ⁱ Megaw, Helen D., 'Crystal structures: a working approach', Studies in physics and chemistry; No. 10. Philadelphia: Saunders, 1973, p. 217.

We considered the possibility that E_d (oxygen) values in oxides are affected by the number and strength of the bonds that oxygen ions have with neighbouring metal ions. As bond length is an indicator of bond strength, we calculated the number and proximity of metal ions around oxygen ions in perovskite and various other oxides and compared these values with the corresponding E_d (oxygen) values (Table 1). The data in Table 1 show that the E_d of oxygen in close packed oxide ion lattices is of the order of 50 eV, regardless of the local environment in which the oxygen ion is located.

5. Conclusion

In this study, the threshold of fast-electron (0.2–0.6 MeV) induced ultraviolet/visible fluorescence was used to determine the E_d values of oxygen in three alkaline earth titanates at room temperature. On the basis that the observed thresholds were due to oxygen displacements, the E_d of oxygen in CaTiO₃, SrTiO₃ and BaTiO₃ was found to be 45 ± 4 eV. This is comparable to the E_d values of oxygen in other oxides. Further work is necessary to more accurately define the shape of the optical emission bands.

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